

| <b>Search Notes</b><br> |          |          |          | Application/Control No.   | Applicant(s)/Patent under Reexamination |      |
|--|----------|----------|----------|---|---|------|
|  |          |          |          | 10/633,243  | BABKA ET AL.                            |      |
|  |          |          |          | Examiner  | Art Unit                                |      |
|  |          |          |          | Alan S. Chen  | 2182                                    |      |
| <b>SEARCHED</b>  |          |          |          | <b>SEARCH NOTES<br/>(INCLUDING SEARCH STRATEGY)</b>   |   |      |
| Class  | Subclass | Date     | Examiner |   | DATE                                    | EXMR |
| 710  | 15-19    | 8/4/2006 | ASC      | (EAST)<br>USPAT; USPGPUB; EPO; JPO;<br>IBM_TDB; DERWENT<br>PLUS; Inventor Search; limited class<br>search | 8/4/2006                                | ASC  |
|  | 52-57    |          |          |   |   |      |
|  | 104      |          |          |   |   |      |
| 713  | 1        |          |          | 101 Help Panel  | 8/4/2006                                | ASC  |
|  | 2        |          |          |   |   |      |
|  | 100      | ↓        | ↓        | 101 Help Panel<br>conditional statements  | 12/22/06                                | ASC  |
|  |          |          |          |   |   |      |
|  |          |          |          | update EAST<br>715/200-866; 710/15-19   | 12/22/06                                | ASC  |
|  |          |          |          |   |   |      |
|  |          |          |          |   |   |      |
| <b>INTERFERENCE SEARCHED</b>   |          |          |          |   |   |      |
| Class  | Subclass | Date     | Examiner |   |   |      |
|  |          |          |          |   |   |      |
|  |          |          |          |   |   |      |
|  |          |          |          |   |   |      |
|  |          |          |          |   |   |      |